L Number	Hits	Search Text	DB	Time stamp
1	0	275/292.ccls. and transfer and reset and	USPAT	2003/12/03
2	130	drain 257/292.ccls. and transfer and reset and	USPAT	14:54 2003/12/03
3	80	drain 257/292.ccls. and (transfer with reset) and drain	USPAT	14:55 2003/12/03
4	4	257/292.ccls. and (transfer with reset) and drain and deplete	USPAT	15:43 2003/12/03
_	370	348/241.ccls.	USPAT	15:43 2003/11/25 12:40
-	1	5953060.pn.	USPAT	2003/11/24 11:52
-	1	4274113.pn.	USPAT	2003/11/24 11:53
-	0	348/241.ccls. and feedback adj conversion adj circuit	USPAT	2003/11/24 12:01
_	4	348/241.ccls. and feedback with impedance	USPAT	2003/11/24 14:10
-	0	348/241.ccls. and reset with selection with on	USPAT	2003/11/24 14:11
-	9	348/241.ccls. and reset with selection	USPAT	2003/11/24 14:48
-	6	348/241.ccls. and reset with detection with amplifier	USPAT	2003/11/24
-	4	348/241.ccls. and (reset with detection with amplifier) and sampling	USPAT	2003/11/24
-	1	348/241.ccls. and cathode and concentration	USPAT	2003/11/24 15:17
-	12	348/241.ccls. and reset with conductive	USPAT	2003/11/24 16:10
-	9	348/241.ccls. and light with conductive	USPAT	2003/11/24 16:17
-	0	348/241.ccls. and deplete with conductive	USPAT	2003/11/24 16:17
-	0	348/241.ccls. and depleted with conductive	USPAT	2003/11/24 16:18
_	5	348/241.ccls. and well with conductive	USPAT	2003/11/24 16:32
-	0	conductive with semiconducter with region with cathode with depleted	USPAT	2003/11/24 16:33
-	0	conductive with semiconductor with region with cathode with depleted	USPAT	2003/11/24 16:33
-	0	conductive with semiconductor with region with cathode with deplete	USPAT	2003/11/24 16:34
-	0	conductive with semiconducter with region with cathode with deplete	USPAT	2003/11/24 16:34
-	0	semiconducter with region with cathode with deplete	USPAT	2003/11/24
-	8	semiconductor with region with cathode with deplete	USPAT	2003/11/24
_	504	gate with electrode with cathode with region	USPAT	2003/11/25
-	55	gate with electrode with cathode with region with drain	USPAT	2003/11/25
_	191864	reset withgate with electrode with cathode with region with drain	USPAT	2003/11/25
_	272	reset with gate with electrode with cathode with region with drain	USPAT	2003/11/25
_	372	348/241.ccls.	USPAT	2003/11/25
_	174	348/241.ccls. and reset	USPAT	2003/11/25
	21	(348/241.ccls. and reset) and cathode	USPAT	2003/11/25
	5	((348/241.ccls. and reset) and cathode) and reset with cathode	USPAT	2003/11/25
_	5	348/241.ccls. and reset with cathode	USPAT	2003/11/25 12:57

-	81	(reset with cathode) with electrode	USPAT	2003/11/25
				12:59
-	275	(reset with cathode) with electrode witrh	USPAT	2003/11/25
		conentration		12:59
_	530471	(reset with cathode) with electrode witrh	USPAT	2003/11/25
		concentration		12:59
_	0	(reset with cathode) with electrode with	USPAT	2003/11/25
		concentration		13:00
-	1	(reset with cathode) with electrode same	USPAT	2003/11/25
		concentration		13:00
-	823	reset with cathode	USPAT	2003/11/25
				13:01
-	35	(gate with electrode with cathode with	USPAT	2003/11/25
ļ		region) with concentration		13:01
-	0	((reset with cathode) with electrode)	USPAT	2003/11/25
1		with concentration		13:01
-	1	(reset with cathode) same (concentration)	USPAT	2003/11/25
				13:06
-	1	(reset with cathode) same (concentration)	USPAT;	2003/11/25
			US-PGPUB;	13:07
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	11	(reset with cathode) and (drain with	USPAT;	2003/11/25
		concentration)	US-PGPUB;	13:07
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	